(Unit's mm)

# **GP1S30**

#### ■ Features

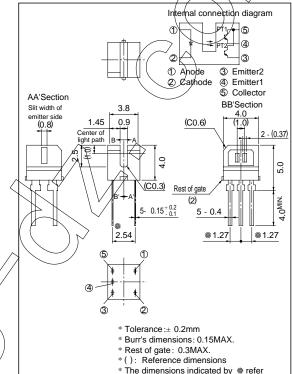
- 1. Compact package
- 2. PWB mouning type
- Double-phase phototransistor output type for detecting of rotation direction and count
- 4. Detecting pitch: 0.6mm

#### ■ Applications

- 1. Mouses
- 2. Cameras

# **Subminiature Photointerrupter**

■ Outline Dimensions



 $(Ta = 25^{\circ}C)$ 

### ■ Absolute Maximum Ratings

	Prameter	Symbol	Rating	Unit	
Input	Forward current <		$I_{\mathrm{F}}$	50	mA
	Reverse voltage	$V_R$	6	V	
	Power dissipation		P	75	mW
Output	Collector-emitter voltage		V <sub>CE1</sub> 0 V <sub>CE2</sub> 0	35	V
	Emitter-collector Voltage		V <sub>E1</sub> CO V <sub>E2</sub> CO	6	V
	Collector current		Ic	Ic 20	
	Collector power dissipation		Pc	75	mW
	Total power dissipation	P <sub>tot</sub>	100	mW	
	Collector power dissipation  Total power dissipation  Operating temperature			- 25 to + 85	°C
	Storage temperature		T stg	- 40 to + 100	°C
*1Soldering temperature			T sol	260	°C

Soldering area

to those measured from the lead base.

<sup>\*1</sup> For MAX. 5 seconds

## **■** Electro-optical Characteristics

Parameter			Symbol	Conditions	MIN.	TYP.	MAX. Unit
Input	Forward voltage		V <sub>F</sub>	$I_F = 20 \text{mA}$	-	1.2	1(4 V
	Reverse current		$I_R$	$V_R = 3V$	-	-	10 ptA
Output	Collector dark current		I <sub>CEO</sub>	$V_{CE} = 20V$	-		100 nA
Transfer characteristics	Collector current		Ic	$V_{CE} = 5V$ , $I_F = 4mA$	250	(-(	1 000 μΑ
	Collector-emitter satu	ration voltage	V <sub>CE(sat)</sub>	$I_F = 8mA, I_C = 125 \mu A$	-	1-/	0,4 / V
	Response time	Rise time	t <sub>r</sub>	$V_{CC} = 5V, I_{C} = 100 \mu A$	- /-	50	_150 μs
		Fall time	$t_{\mathrm{f}}$	$R_L = 1~000~\Omega$	7	500	150 μs

Fig. 1 Forward Current vs. Ambient **Temperature** 

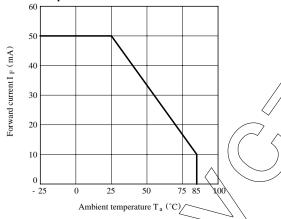


Fig. 3 Forward Current vs. Forward Voltage

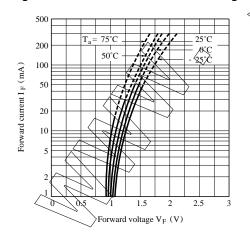


Fig. 2 Power Dissipation vs.

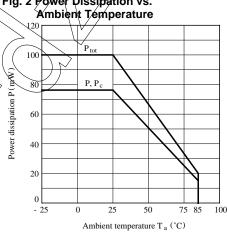


Fig. 4 Collector Current vs. Forward Current

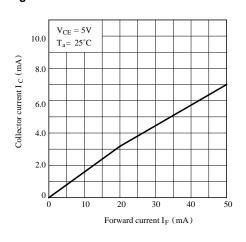


Fig. 5 Collector Current vs. Collector-emitter Voltage

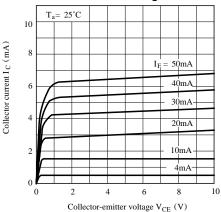
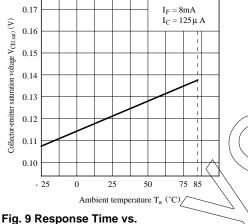


Fig. 7 Collector-emitter Saturation Voltage vs. Ambient Temperature



**Load Resistance** 

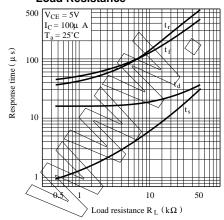


Fig. 6 Collector Current vs. **Ambient Temperature** 500 B 400

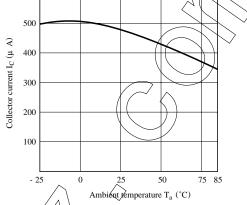
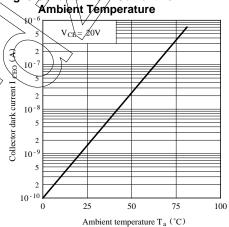


Fig. 8 Collector Dark Current vs.



#### **Test Circuit for Response Time**

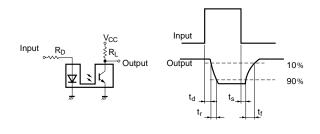
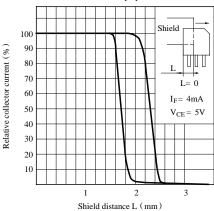
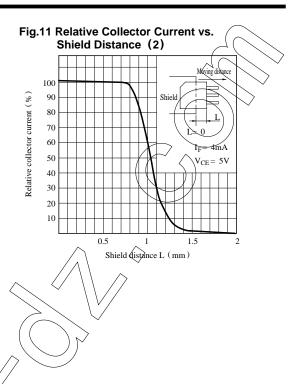
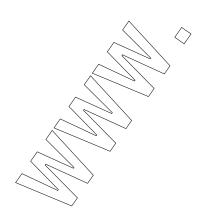


Fig.10 Relative Collector Current vs. Shield Distance (1)



• Please refer to the chapter "Precautions for Use".





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